



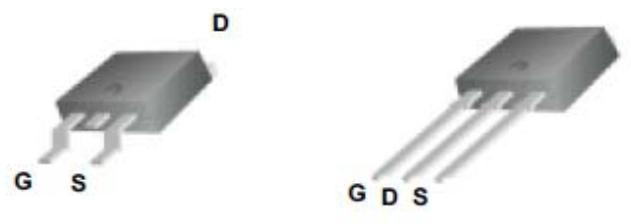
Technologies Int'l

## WFU5N60/WFD5N60

600V N-Channel MOSFET

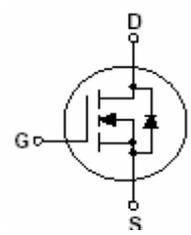
### Features

- Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Extended Safe Operating Area
- Unrivalled Gate Charge : 15 nC (Typ.)
- BVDSS=600V, ID=4.5A
- Lower  $R_{DS(on)}$  : 2.5Ω (Max) @VG=10V
- 100% Avalanche Tested



TO-252

TO-251



G-Gate, D-Drain, S-Source

### Absolute Maximum Ratings $T_c=25^\circ C$ unless other wise noted

Symbol	Parameter	WFU/D5N60	Units
$V_{DSS}$	Drain-Source Voltage	600	V
$I_D$	Drain Current -continuous ( $T_c=25^\circ C$ )	4.5	A
	-continuous ( $T_c=100^\circ C$ )	1.8	A
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avanche Energy (Note1)	240	mJ
$I_{AR}$	Avalanche Current (Note2)	4	A
$P_D$	Power Dissipation ( $T_c=25^\circ C$ )	44	W
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 ~ +150	$^\circ C$
TL	Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	300	$^\circ C$

### Thermal Characteristics

Symbol	Parameter	Typ.	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	--	2.56	$^\circ C/W$
$R_{\theta CA}$	Thermal Resistance, Junction to Ambient*	--	50	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	--	110	$^\circ C/W$

\*When mounted on the minimum pad size recommended (PCB mounted)

**Electrical Characteristics**  $T_c=25^\circ\text{C}$  unless other wise noted

Symbol	Parameter	Test Condition	Min.	Typ.	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=250\ \mu\text{A}, V_{GS}=0$	600	--	--	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D=250\ \mu\text{A}$ , Reference to $25^\circ\text{C}$	--	0.6	--	$V/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{ds}=500\text{V}, V_{gs}=0\text{V}$	--	--	1	$\mu\text{A}$
		$V_{ds}=480\text{V}, T_c=125^\circ\text{C}$			10	$\mu\text{A}$
$I_{GSSF}$	Gate-body leakage Current, Forward	$V_{gs}=+30\text{V}, V_{ds}=0\text{V}$	--	--	100	nA
$I_{GSSR}$	Gate-body leakage Current, Reverse	$V_{gs}=-30\text{V}, V_{ds}=0\text{V}$	--	--	-100	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$I_D=250\ \mu\text{A}, V_{ds}=V_{gs}$	2	--	4	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$I_D=2.25\text{A}, V_{gs}=10\text{V}$	--	--	2.5	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=25\text{V}, V_{GS}=0,$ $f=1.0\text{MHz}$	--	515	670	pF
$C_{oss}$	Output Capacitance		--	55	72	pF
$C_{rss}$	Reverse Transfer Capacitance		--	6.5	8.5	pF
<b>Switching Characteristics</b>						
$T_d(on)$	Turn-On Delay Time	$V_{DD}=300\text{V}, I_D=4.5\text{A},$ $R_G=25\ \Omega$ (Note 3,4)	--	150	30	nS
$T_r$	Turn-On Rise Time		--	42	90	nS
$T_d(off)$	Turn-Off Delay Time		--	38	85	nS
$T_f$	Turn-Off Fall Time		--	46	100	nS
$Q_g$	Total Gate Charge	$V_{DS}=480, V_{GS}=10\text{V},$ $I_D=4.5\text{A}$ (Note 3,4)	--	15	19	nC
$Q_{gs}$	Gate-Source Charge		--	2.	--	nC
$Q_{gd}$	Gate-Drain Charge			6.6	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current		--	--	4.5	A
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current		--	--	18	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$I_D=4.5\text{A}$	--	--	1.25	V
$t_{rr}$	Reverse Recovery Time	$I_S=4.5\text{A}, V_{GS}=0\text{V}$	--	300	--	nS
$Q_{rr}$	Reverse Recovery Charge	$di_f/dt=100\text{A}/\mu\text{s}$ (Note3)	--	2.2	--	$\mu\text{C}$
*Notes	1, $L=27.5\text{mH}, I_{AS}=4\text{A}, V_{DD}=50\text{V}, R_G=25\ \Omega$ , Starting $T_J=25^\circ\text{C}$ 2, Repetitive Rating : Pulse width limited by maximum junction temperature 3, Pulse Test : Pulse Width $\leq 300\ \mu\text{s}$ , Duty Cycle $\leq 2\%$ 4, Essentially Independent of Operating Temperature					

# Typical Characteristics

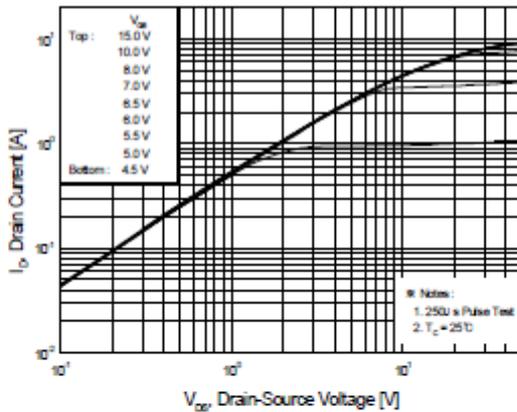


Figure 1. On-Region Characteristics

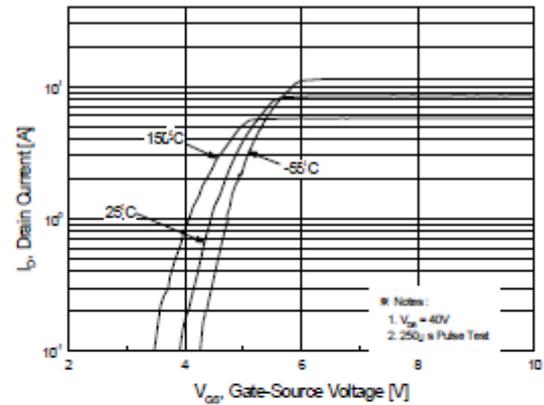


Figure 2. Transfer Characteristics

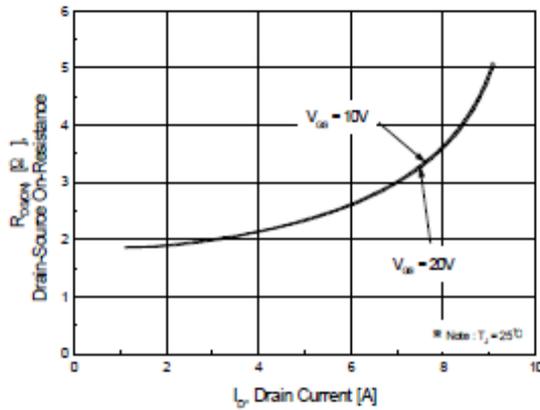


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

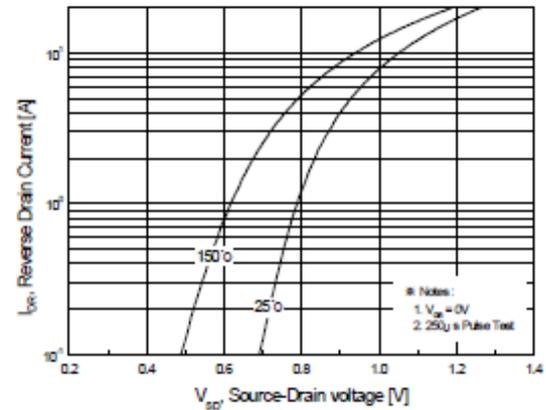


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

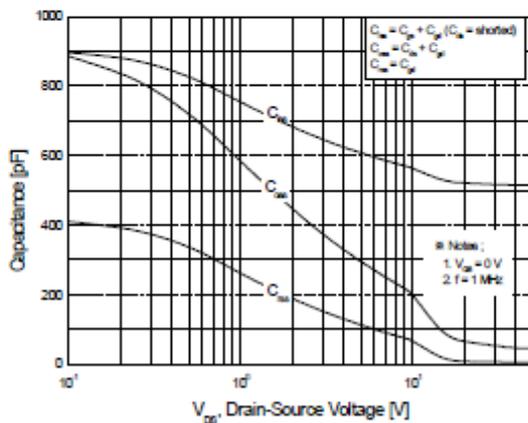


Figure 5. Capacitance Characteristics

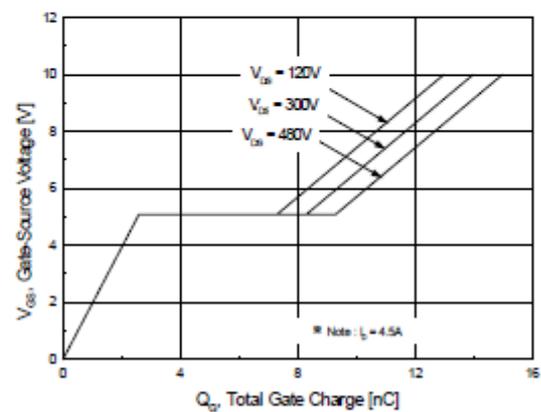
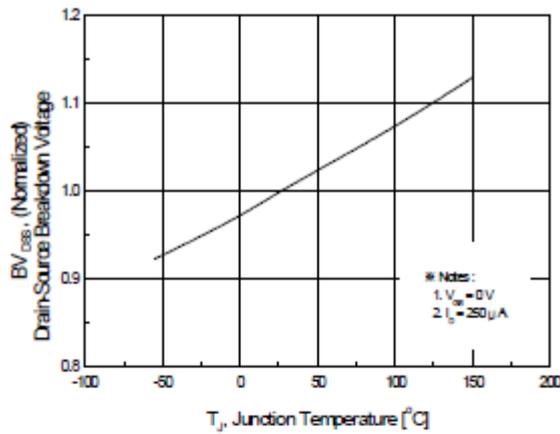
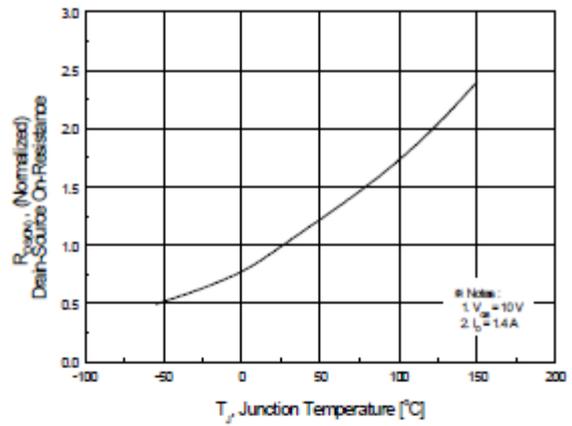


Figure 6. Gate Charge Characteristics

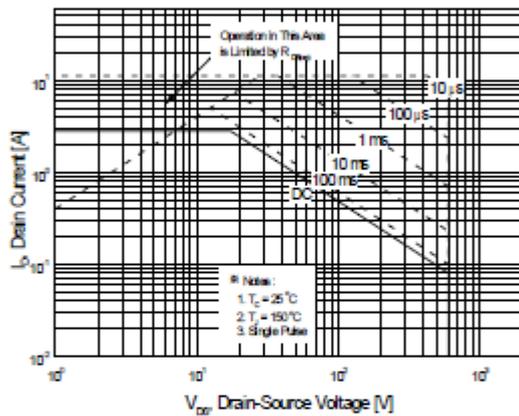
**Typical Characteristics (Continued)**



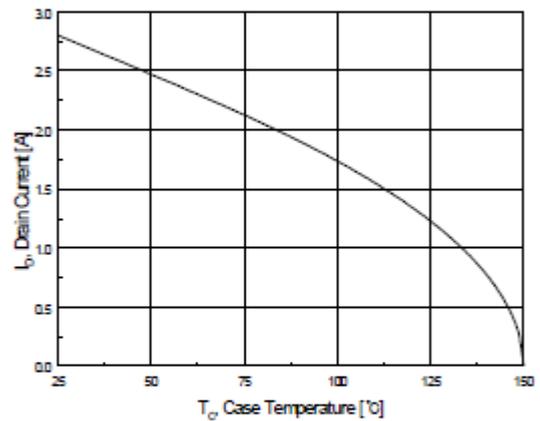
**Figure 7. Breakdown Voltage Variation vs Temperature**



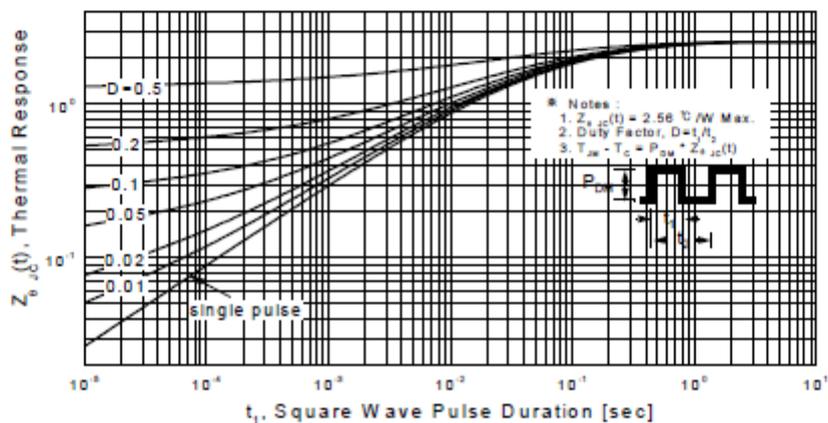
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**

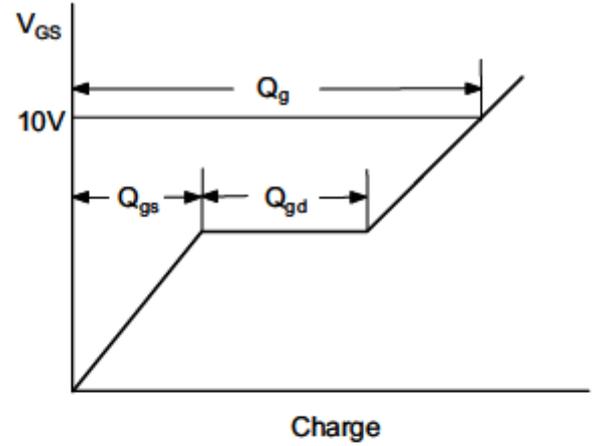
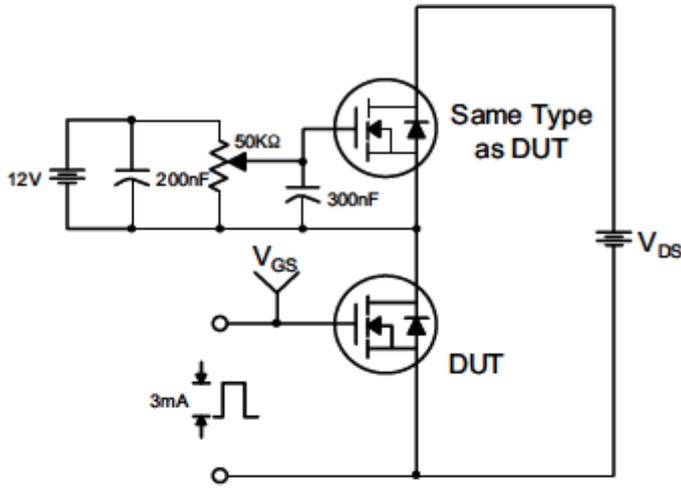


**Figure 10. Maximum Drain Current vs Case Temperature**

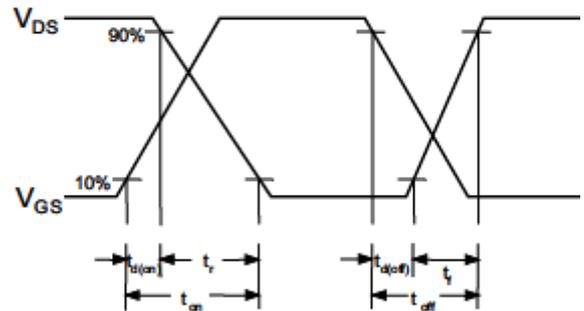
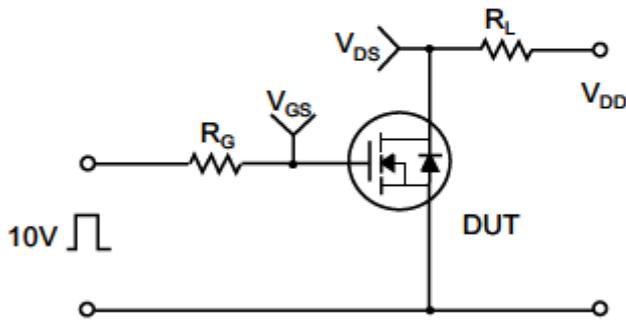


**Figure 11. Transient Thermal Response Curve**

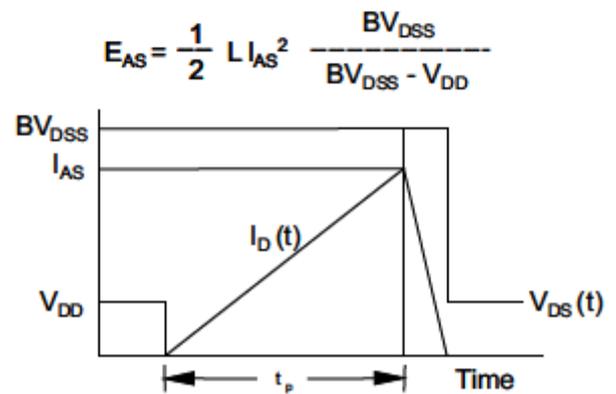
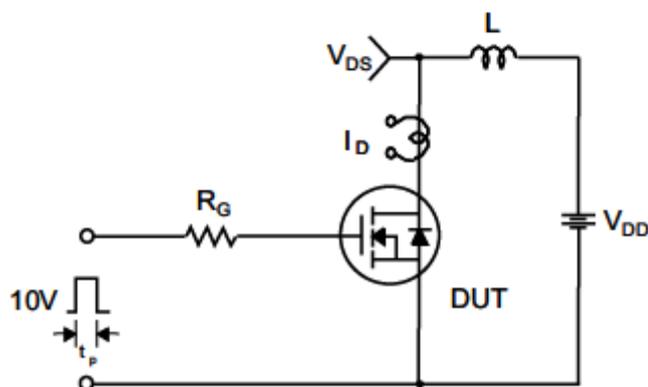
**Gate Charge Test Circuit & Waveform**



**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching Test Circuit & Waveforms**



Peak Diode Recovery dv/dt Test Circuit & Waveforms

